



WANSEMI
万晶半导体

WX012N10LL

N-channel Enhancement Mode Power MOSFET

TOLL/100V/ $\pm 20\text{V}$ /3.0V/467A/0.98m Ω

Rev1.1



100V, 0.98 mΩ, 467A, N-channel MOSFET

1. Features

- ◆ Excellent R_{DS(ON)} and Low Gate Charge
- ◆ 100% UIS Tested
- ◆ 100% ΔV_{Ds} Tested
- ◆ 100% DVDS Tested
- ◆ 100% R_G Tested
- ◆ Halogen-free; RoHS-compliant

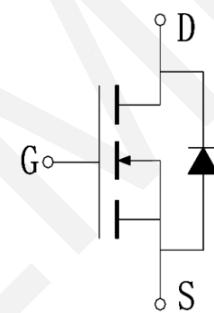
V _{DS}	R _{DS(on)} Typ.	I _D Max.
100V	0.98mΩ @10V	467A

2. Applications

- ◆ Load Switch
- ◆ PWM Application
- ◆ Power Management



Pin Description



Schematic Diagram

3. Package Marking and Ordering Information

Part no.	Package	Marking	PCS/Reel	PCS/CTN.
WX012N10LL	TOLL	012N10	2,000	16,000

4. Absolute Max Ratings at Ta=25°C (Note1)

Parameter		Symbol	Maximum	Units
Drain to Source Voltage		V _{DSS}	100	V
Gate to Source Voltage		V _{GSS}	±20	V
Drain Current (DC)	T C = 25°C	I _D	467	A
	T C = 100°C	I _D	295	A
Drain Current (Pulse), PW≤300μs		I _{DM}	1868	A
Avalanche Energy, Single Pulsed		E _{AS}	1987	mJ
Total Dissipation	T C = 25°C	P _D	500	W
	T C = 100°C	P _D	200	W
Junction Temperature		T _j	150	°C
Storage Temperature		T _{stg}	-55 to +150	°C

Note 1: Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.



5.Thermal Resistance Ratings (Note 2)

Parameter	Symbol	Value	Unit
Junction to Ambient	R _{θJA}	33	°C/W
Junction to case	R _{θJC}	0.35	°C/W

Note 2: When mounted on 1 inch square copper board t ≤ 10sec The value in any given application depends on the user's specific board design.

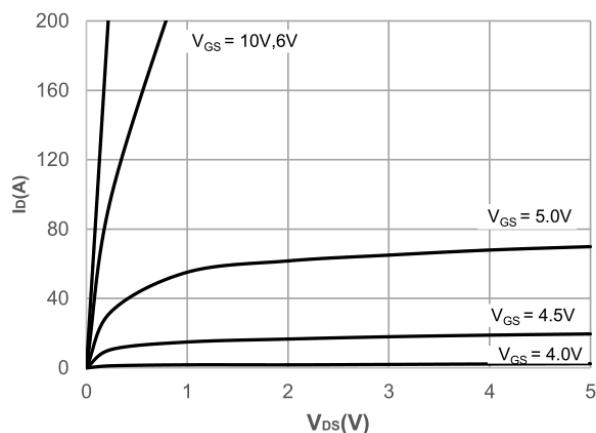
6.Electrical Characteristics at Ta=25°C (Note 2)

Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Units
Drain to Source Breakdown Voltage	V _{(BR)DSS}	I _D = 250μA, V _{GS} = 0V	100	-	-	V
Zero-Gate Voltage Drain Current	I _{DSS}	V _{DS} = 90V, V _{GS} = 0V	-	-	1	μA
Gate to Source Leakage Current	I _{GSS}	V _{GS} = ±20V, V _{DS} = 0V	-	-	±100	nA
Gate Threshold Voltage	V _{GS(th)}	V _{DS} =V _{GS} , I _D =250μA	2.0	3.0	4.0	V
Static Drain to Source On-State Resistance	R _{DS(on)}	I _D =20A, V _{GS} =10V	-	0.98	1.3	mΩ
Input Capacitance	C _{iss}	V _{GS} =0V, V _{DS} =50V, Frequency=1.0MHz	9543	13360	18036	pF
Output Capacitance	C _{oss}		3652	5113	6902	pF
Reverse Transfer Capacitance	C _{rss}		87	122	164	pF
Turn-on Delay Time	t _{d(on)}	V _{DS} = 50V, I _D =20A V _{GS} = 10V, R _{GEN} =3Ω	-	41	-	ns
Rise Time	t _r		-	69	-	ns
Turn-off Delay Time	t _{d(off)}		-	157	-	ns
Fall Time	t _f		-	92	-	ns
Total Gate Charge	Q _g	V _{DS} = 50V, V _{GS} =10V, I _D =20A	155	217	293	nC
	Q _{gs}		47	65	88	nC
	Q _{gd}		41	57	77	nC
Diode Forward Voltage	V _{FSD}	I _S = 20A, V _{GS} = 0	0.4	0.85	1.2	V

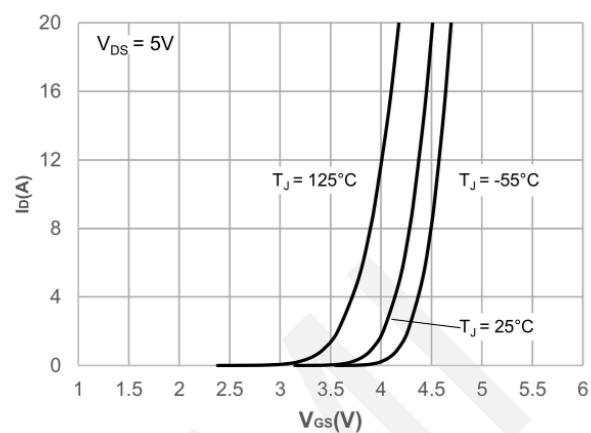
Note 2: Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.



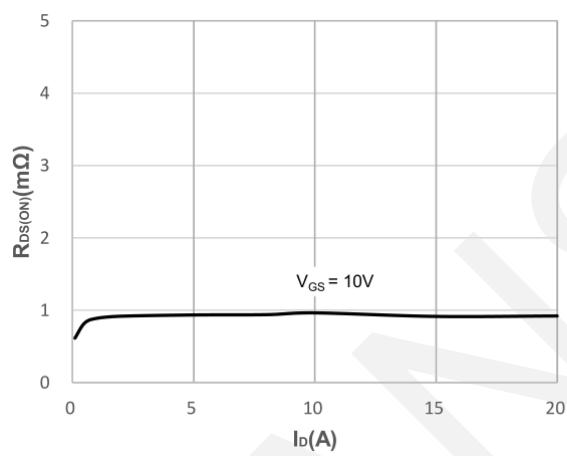
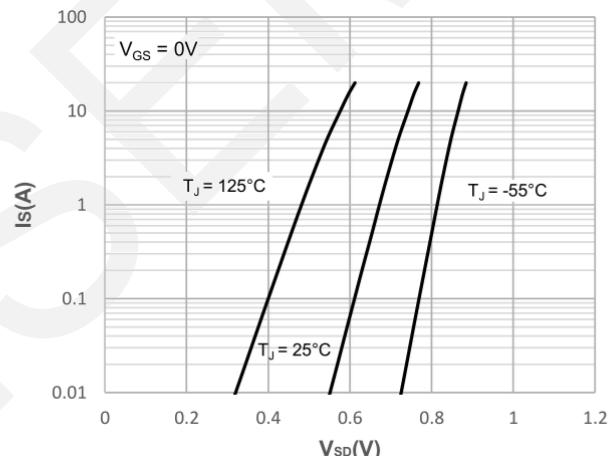
7.Typical electrical and thermal characteristics



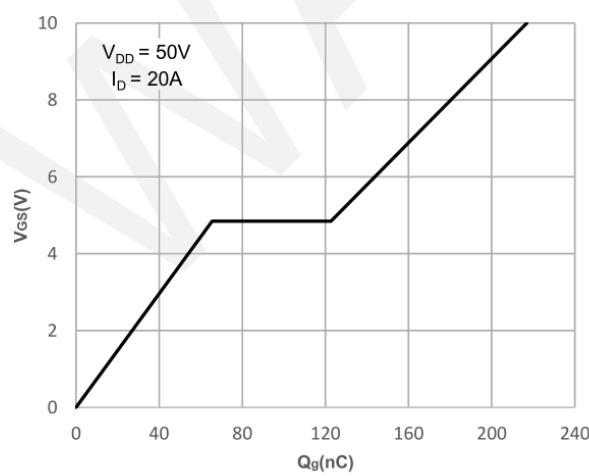
Saturation Characteristics



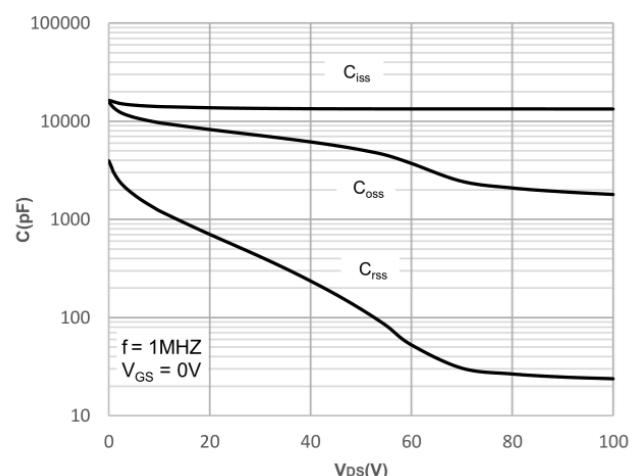
Transfer Characteristics

 $R_{DS(on)}$ vs.Drain Current

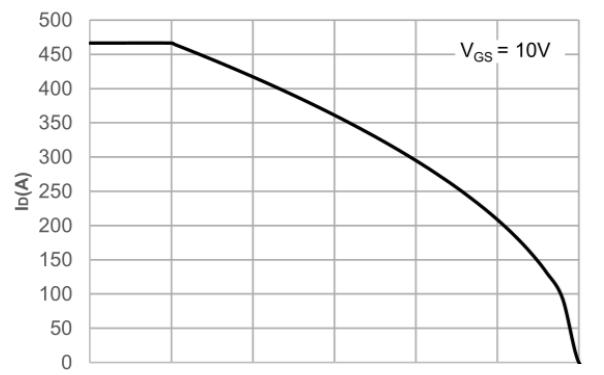
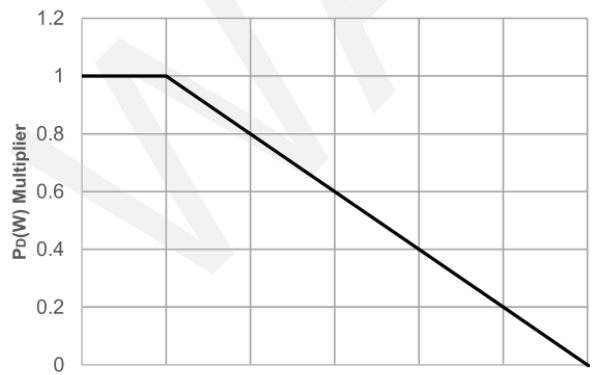
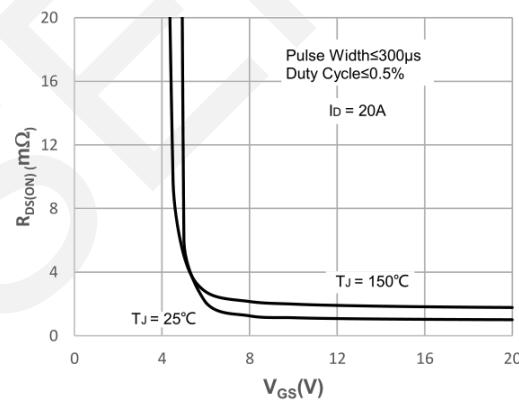
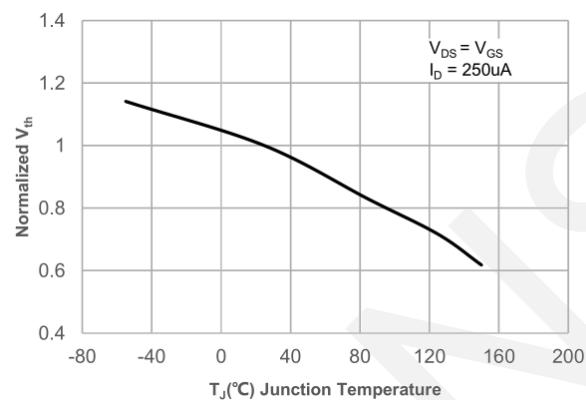
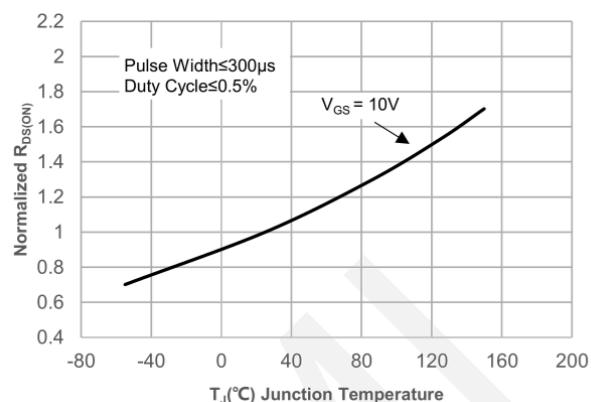
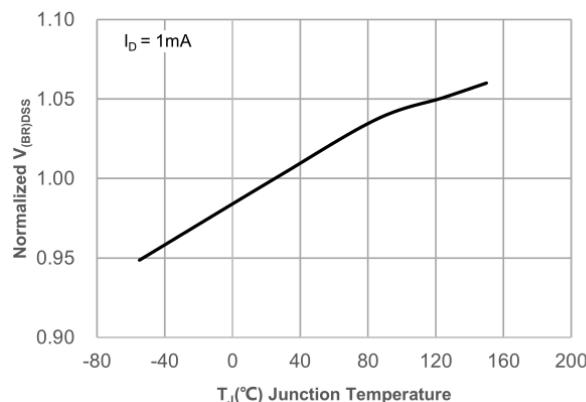
Body-Diode Characteristics

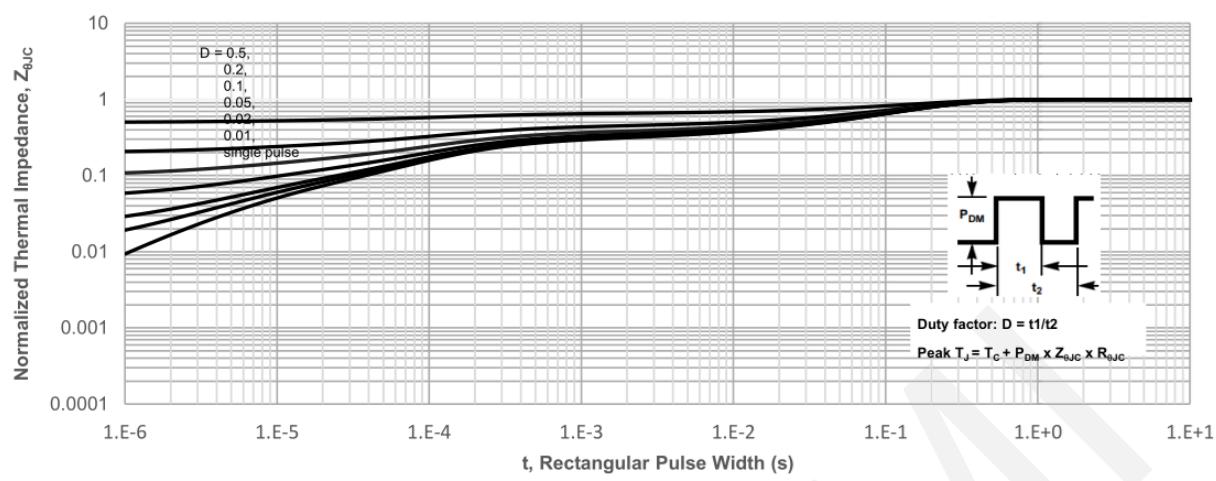


Gate Charge Characteristics

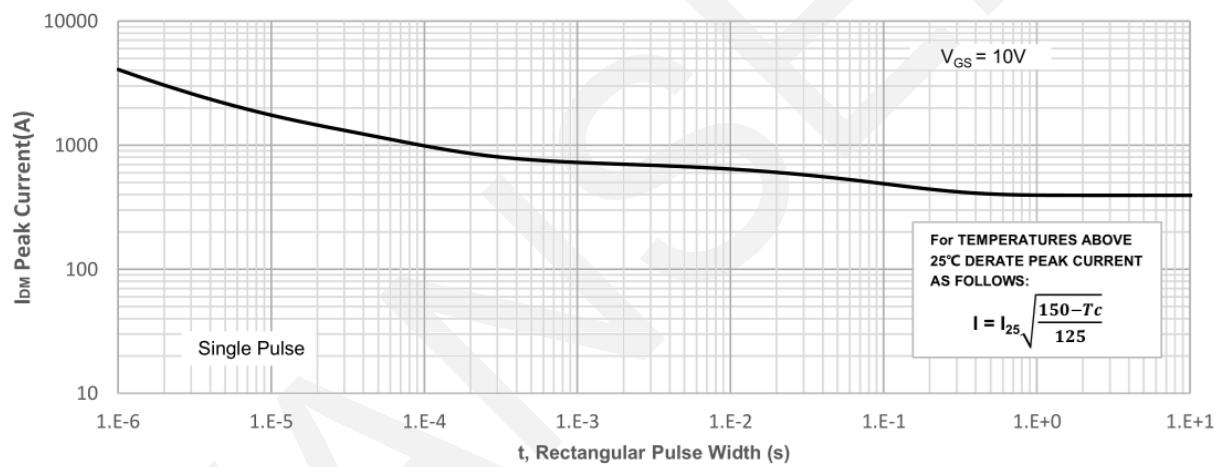


Capacitance Characteristics





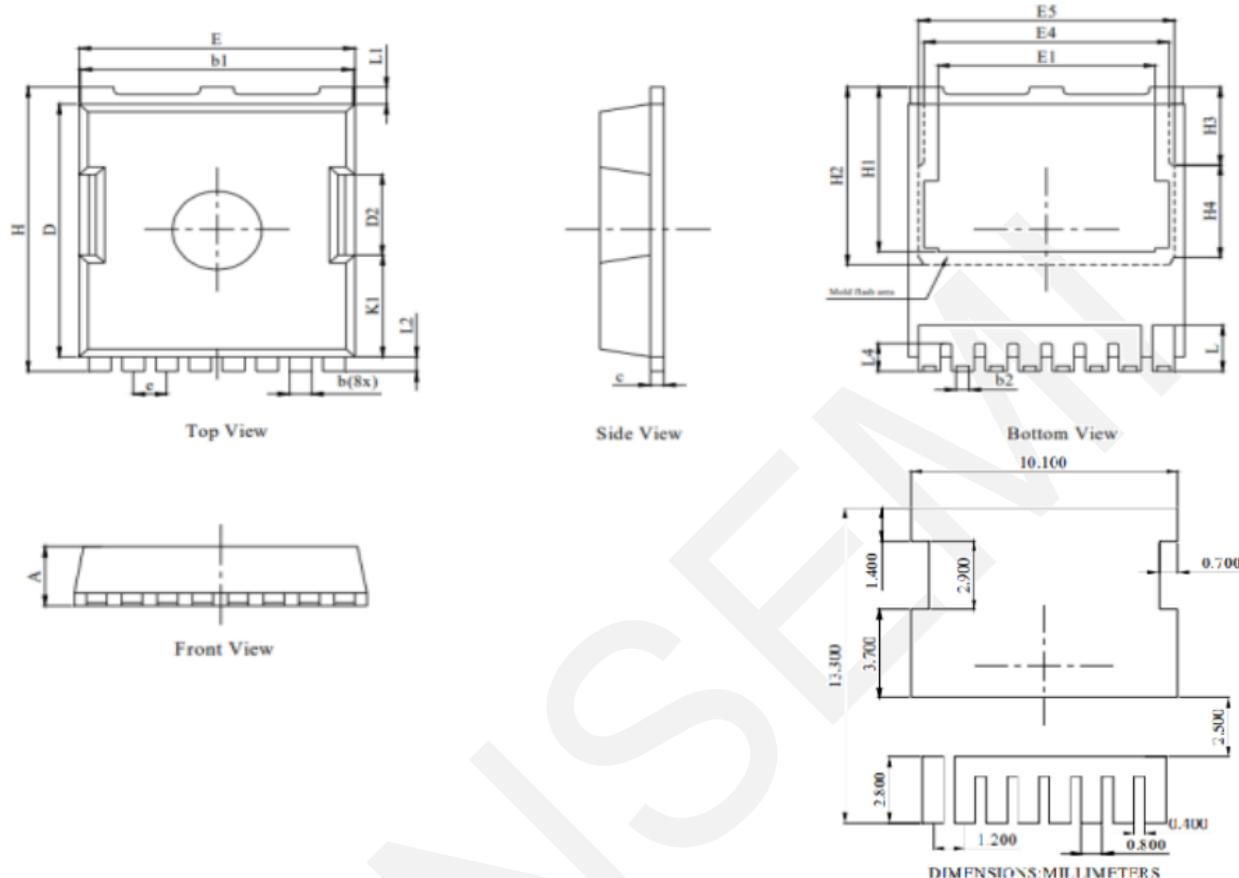
Normalized Maximum Transient Thermal Impedance



Peak Current Capacity



8.Package Dimensions



DIM.	MILLIMETER		
	MIN	NOM	MAX
A	2.20	2.30	2.50
b	0.70	0.80	0.90
b1	9.70	9.80	9.90
b2	0.42	0.46	0.50
C	0.40	0.50	0.65
D	10.28	10.38	10.58
D2		3.30	
E	9.70	9.90	10.10
E1		7.80	
E4		8.80	
E5		9.20	
e	1.20(BSC)		
H	11.48	11.68	11.88
H1	6.55	6.75	6.85
H2		7.30	
H3		3.20	
H4		3.80	
K1		4.18	
L	1.70	1.90	2.10
L1		0.70	
L2		0.60	
L4	1.00	1.15	1.30

9. Important Notice

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